

Search Notes**Application/Control No.**

10/673,963

Examiner

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Applicant(s)/Patent under Reexamination

SCHEIBLE ET AL.

Art Unit

2121

SEARCHED

Class	Subclass	Date	Examiner
700	20	3/25/2005	SC
455	431	3/25/2005	SC
180	65.3	3/25/2005	SC
340	693.1	3/25/2005	SC

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPAT, US_PGPUB, JPO, EPO, DERWENT, IBM_TDB)	3/25/2005	SC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner